

<b>Notice of References Cited</b>	Application/Control No. 09/885,315	Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
	Examiner Kristie Shingles	Art Unit 2141	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,738,352	05-2004	Yamada et al.	370/238
*	B	US-6,424,992	07-2002	Devarakonda et al.	709/203
*	C	US-5,812,549	09-1998	Sethu, Harish	370/389
*	D	US-2006/0112176	05-2006	Liu et al.	709/223
*	E	US-2006/0109853	05-2006	Matsuzawa et al.	370/400
*	F	US-6,272,548	08-2001	Cotter et al.	709/239
*	G	US-6,754,843	06-2004	Lu et al.	714/4
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.